

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

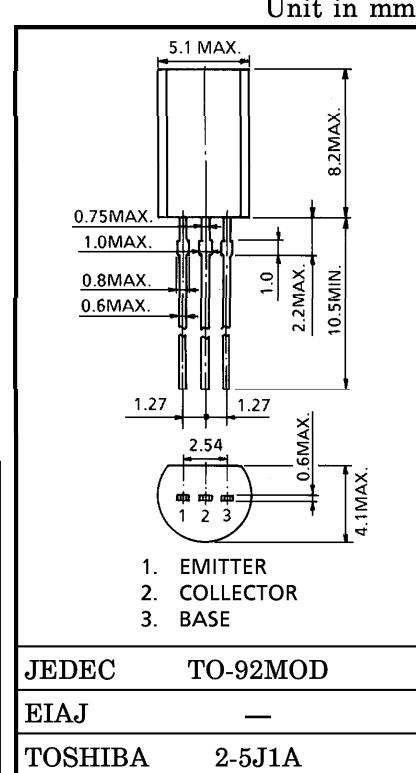
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HIGH SPEED SWITCHING APPLICATION FOR INVERTER LIGHTING
SYSTEM

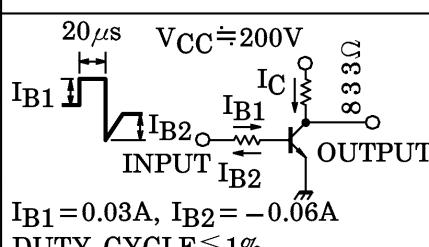
- Suitable for RCC Circuit. (Guaranteed small current h_{FE})
: $h_{FE} = 13$ (Min.) ($I_C = 1\text{mA}$)
- High Speed : $t_r = 0.5\mu\text{s}$ (Max.), $t_f = 0.3\mu\text{s}$ (Max.) ($I_C = 0.24\text{A}$)
- High Voltage : $V_{CEO} = 400\text{V}$

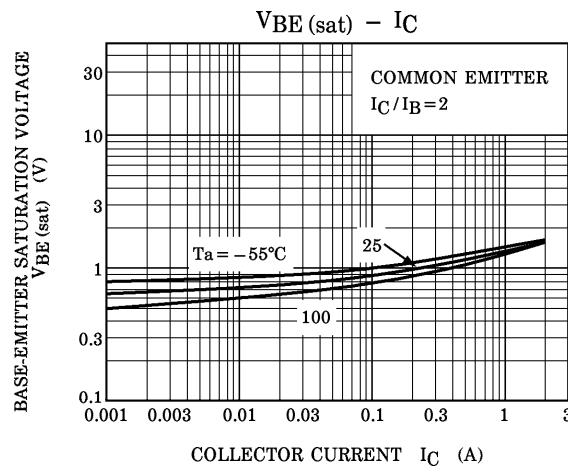
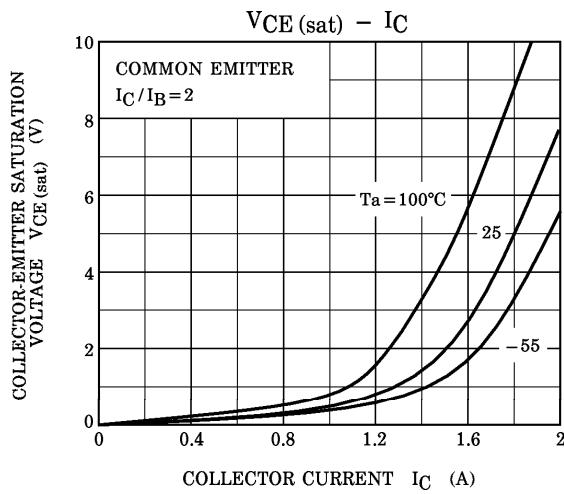
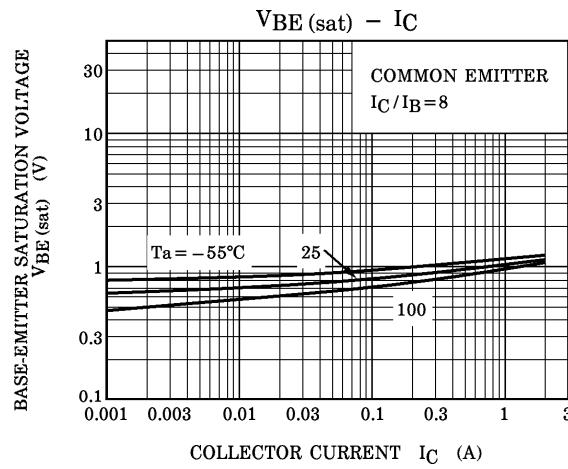
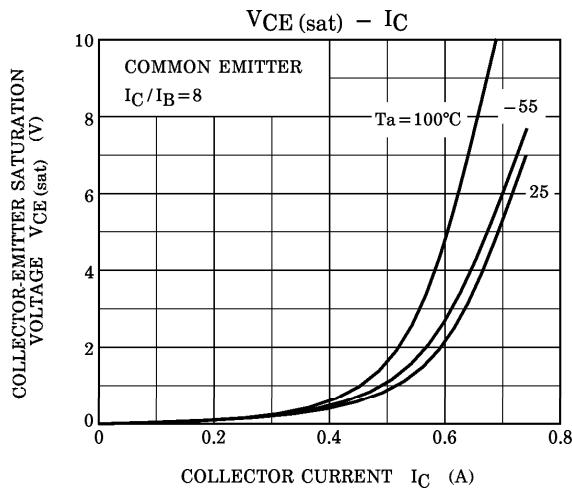
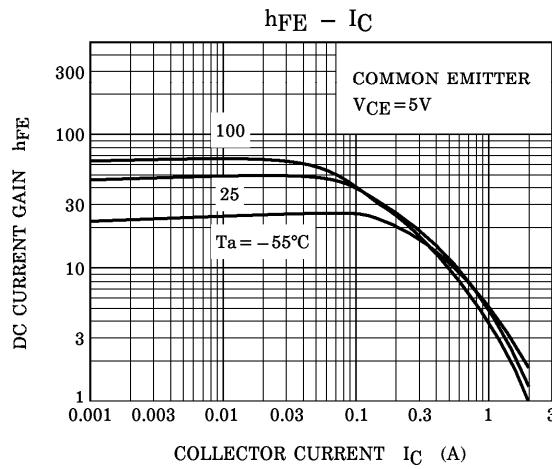
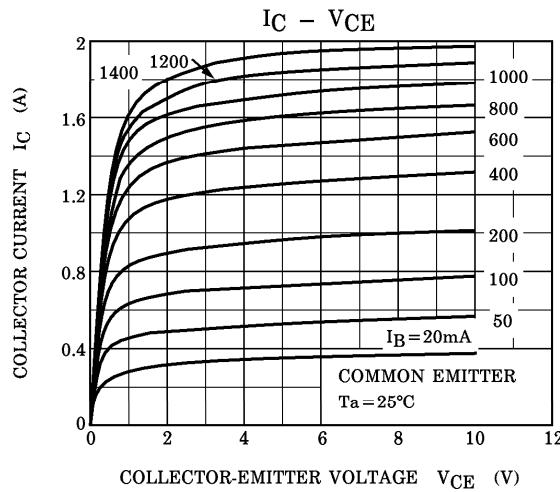
MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

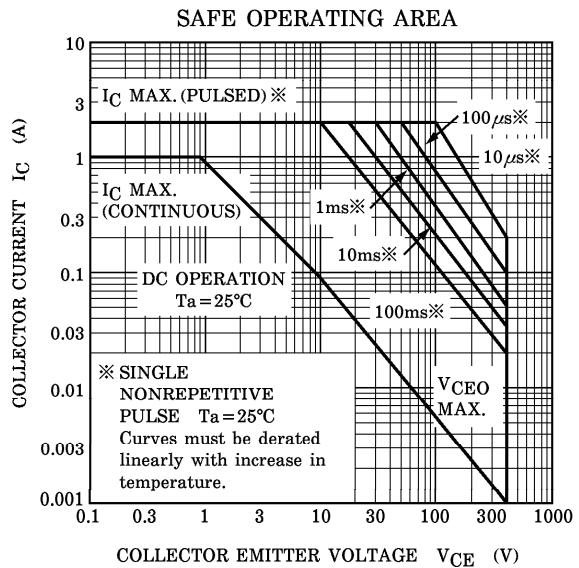
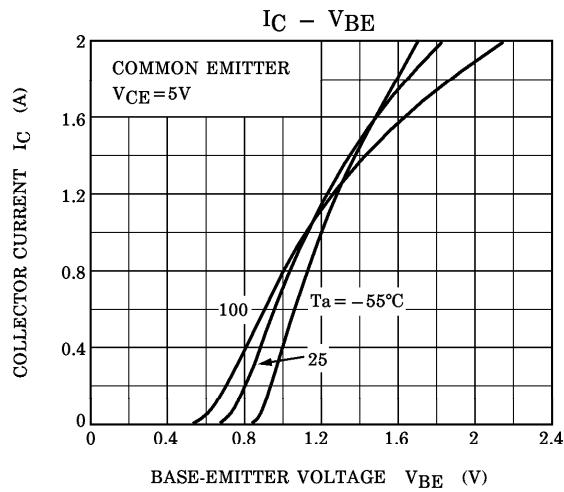
CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V_{CBO}	400	V
Collector-Emitter Voltage	V_{CEO}	400	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current	DC	I_C	1
	Pulse	I_{CP}	2
Base Current	I_B	0.5	A
Collector Power Dissipation	P_C	0.9	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	$-55\text{--}150$	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
Collector Cut-off Current	I_{CBO}	$V_{CB} = 320\text{V}, I_E = 0$	—	—	100	μA	
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 7\text{V}, I_C = 0$	—	—	100	μA	
Collector-Base Breakdown Voltage	$V_{(\text{BR})\text{CBO}}$	$I_C = 1\text{mA}, I_B = 0$	400	—	—	V	
Collector-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = 10\text{mA}, I_B = 0$	400	—	—	V	
DC Current Gain	h_{FE} (1)	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$	13	—	—		
	h_{FE} (2)	$V_{CE} = 5\text{V}, I_C = 0.04\text{A}$	20	—	65		
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 0.2\text{A}, I_B = 25\text{mA}$	—	—	1.0	V	
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = 0.2\text{A}, I_B = 25\text{mA}$	—	—	1.3	V	
Switching Time	Rise Time	t_r		—	—	0.5	μs
	Storage Time	t_{stg}		—	—	5.0	
	Fall Time	t_f		—	—	0.3	





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